


<b>Search Notes</b>  	<b>Application/Control No.</b>  10673267	<b>Applicant(s)/Patent Under Reexamination</b>  PERETS ET AL.
	<b>Examiner</b>  Lee, Siu M	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	262, 316, 341, 349	12/18/2006	Siu M. Lee
455	571, 343, 127, 419, 67.3, 263, 312, 337		

SEARCH NOTES		
Search Notes	Date	Examiner
US-PGPUB	12/18/2006	Siu M. Lee
USPAT	12/18/2006	Siu M. Lee
USOCR	12/18/2006	Siu M. Lee
EPO	12/18/2006	Siu M. Lee
JPO	12/18/2006	Siu M. Lee
DERWENT	12/18/2006	Siu M. Lee
IBM_TDB	12/18/2006	Siu M. Lee
discussed the application with Chieh Fan	12/19/2006	Siu M. Lee

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner